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(PTO-1449)		APPLICANT Yasuhiro TAKEDA, et al.			
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U.S. PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear
					Translation Yes No
MK		JP 5-102477 (w/ English Abstract)	04/23/1993	MATSUSHITA ELECTRIC IND. CO., LTD.	
MK		JP 2001-156291 A (w/ English Abstract)	06/08/2001	NEC CORP.	
MK		JP 2000-323710 A (w/ English Abstract)	11/24/2000	CHARTERED SEMICONDUCTOR MFG. LTD.	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)					
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